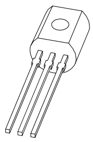


PBSS9110AS

100 V, 1 A PNP low V_{CEsat} (BISS) transistor

Rev. 03 — 21 November 2009 Product data sheet

1. Product profile

1.1 General description

PNP low V_{CEsat} (BISS) transistor in a SOT54 (SC-43/TO-92) plastic package.

1.2 Features

- SOT54 package
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High efficiency leading to less heat generation

1.3 Applications

- Major application segments:
  - Automotive 42 V power
  - Telecom infrastructure
  - Industrial
- Peripheral driver:
  - Driver in low supply voltage applications (e.g. lamps and LEDs)
  - Inductive load driver (relays, buzzers and motors)
- DC-to-DC converter

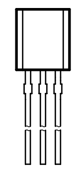
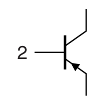
1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{CEO}	collector-emitter voltage		-	-	–100	V
I_C	collector current (DC)		-	-	–1	A
I_{CM}	peak collector current		-	-	–3	A
R_{CEsat}	equivalent on-resistance		-	-	320	mΩ

2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Symbol
1	collector		
2	base		
3	emitter		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PBSS9110AS	-	plastic single-ended leaded (through hole) package; 3 leads	SOT54

4. Marking

Table 4. Marking

Type number	Marking code
PBSS9110AS	9110AS[1]

[1] Made in Hong Kong

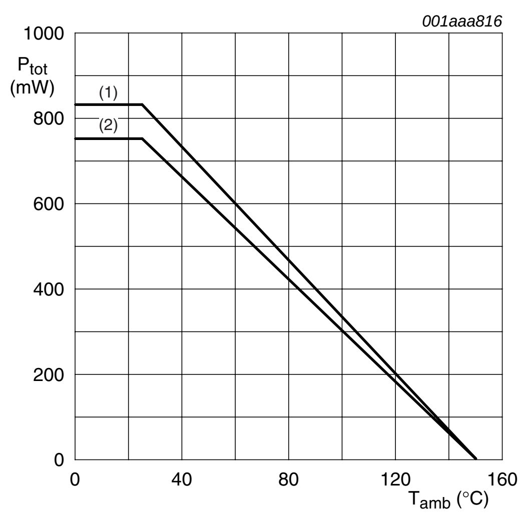
5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter		-	–120	V
V_{CEO}	collector-emitter voltage	open base		-	–100	V
V_{EBO}	emitter-base voltage	open collector		-	–5	V
I_{CM}	peak collector current	$T_{j(max)}$		-	–3	A
I_C	collector current (DC)			-	–1	A
I_B	base current (DC)			-	–0.3	A
P_{tot}	total power dissipation	$T_{amb} \leq 25$ °C	[1]	-	830	mW
T_j	junction temperature			-	150	°C
T_{amb}	operating ambient temperature			–65	+150	°C
T_{stg}	storage temperature			–65	+150	°C

[1] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, standard footprint.



(1) 1cm² collector mounting pad

(2) Standard footprint

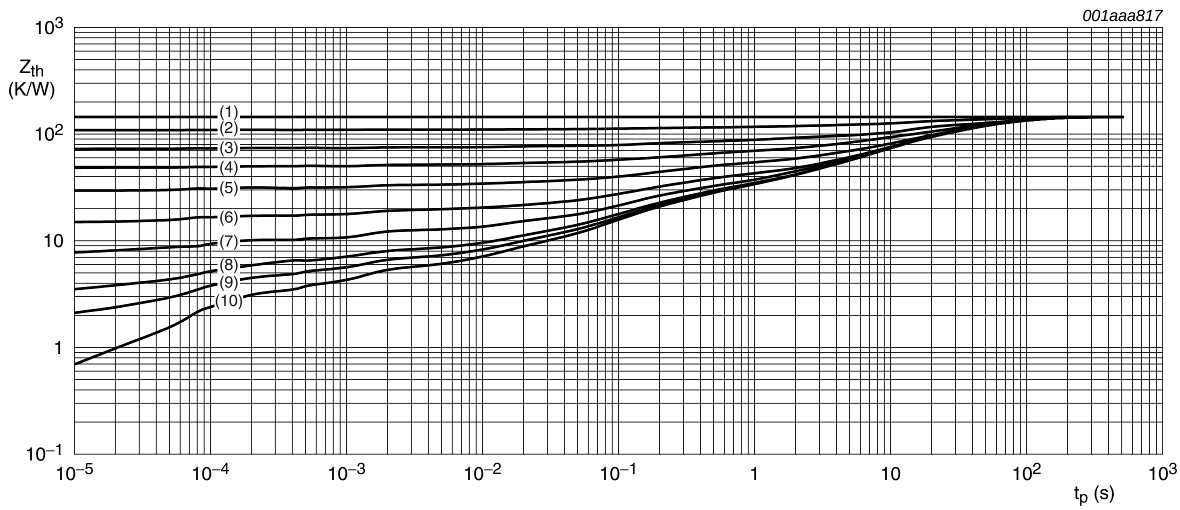
Fig 1. Power derating curves

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Typ	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1]	150	K/W

[1] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, standard footprint.



Mounted on FR4 PCB; standard footprint

(1) $\delta = 1$

(2) $\delta = 0.75$

(3) $\delta = 0.5$

(4) $\delta = 0.33$

(5) $\delta = 0.2$

(6) $\delta = 0.1$

(7) $\delta = 0.05$

(8) $\delta = 0.02$

(9) $\delta = 0.01$

(10) $\delta = 0$

Fig 2. Transient thermal impedance as a function of pulse time; typical values

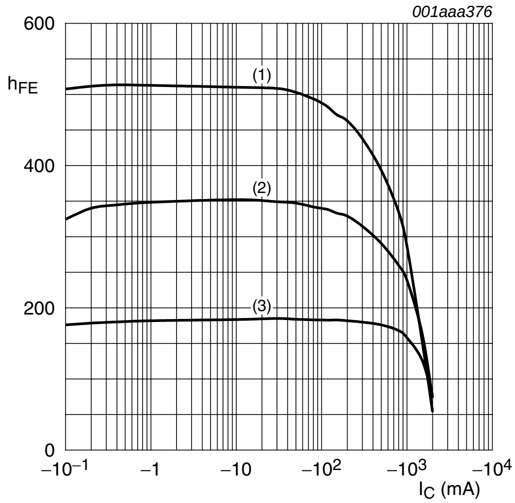
7. Characteristics

Table 7. Characteristics

T_{amb} = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ	Max	Unit
I_{CBO}	collector-base cut-off current	V_{CB} = –80 V; I_E = 0 A		-	-	–100	nA
		V_{CB} = –80 V; I_E = 0 A; T_j = 150 °C		-	-	–50	μA
I_{CES}	collector-emitter cut-off current	V_{CE} = –80 V; V_{BE} = 0 V		-	-	–100	nA
I_{EBO}	emitter-base cut-off current	V_{EB} = –4 V; I_C = 0 A		-	-	–100	nA
h_{FE}	DC current gain	V_{CE} = –5 V; I_C = –1 mA		150	-	-	
		V_{CE} = –5 V; I_C = –250 mA		150		-	
		V_{CE} = –5 V; I_C = –0.5 A	[1]	150	-	450	
		V_{CE} = –5 V; I_C = –1 A	[1]	125	-	-	
V_{CEsat}	collector-emitter saturation voltage	I_C = –250 mA; I_B = –25 mA		-	-	–120	mV
		I_C = –500 mA; I_B = –50 mA		-	-	–180	mV
		I_C = –1 A; I_B = –100 mA		-	-	–320	mV
R_{CEsat}	equivalent on-resistance	I_C = –1 A; I_B = –100 mA	[1]	-	170	320	mΩ
V_{BEsat}	base-emitter saturation voltage	I_C = –1 A; I_B = –100 mA		-	-	–1.1	V
V_{BEon}	base-emitter turn-on voltage	I_C = –1 A; V_{CE} = –5 V		-	-	–1.0	V
f_T	transition frequency	I_C = –50 mA; V_{CE} = –10 V; f = 100 MHz		100	-	-	MHz
C_c	collector capacitance	I_E = I_e = 0 A; V_{CB} = –10 V; f = 1 MHz		-	-	17	pF

[1] Pulse test $t_p \leq 300$ μs; $\delta \leq 0.02$.



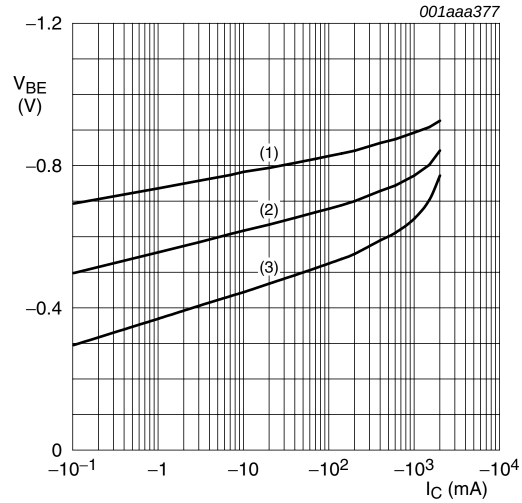
V_{CE} = −10 V

(1) T_{amb} = 100 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = −55 °C

Fig 3. DC current gain as a function of collector current; typical values



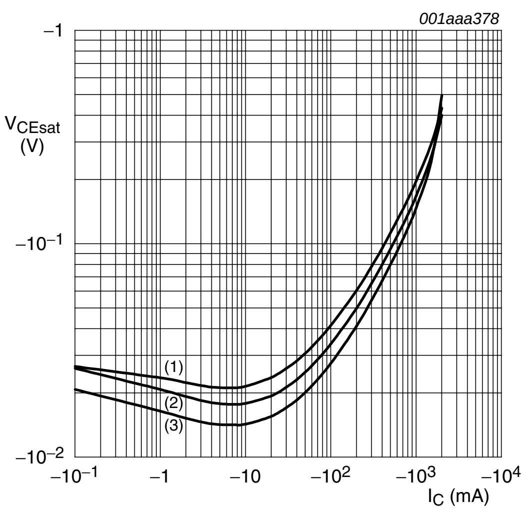
V_{CE} = −10 V

(1) T_{amb} = −55 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = 100 °C

Fig 4. Base-emitter voltage as a function of collector current; typical values



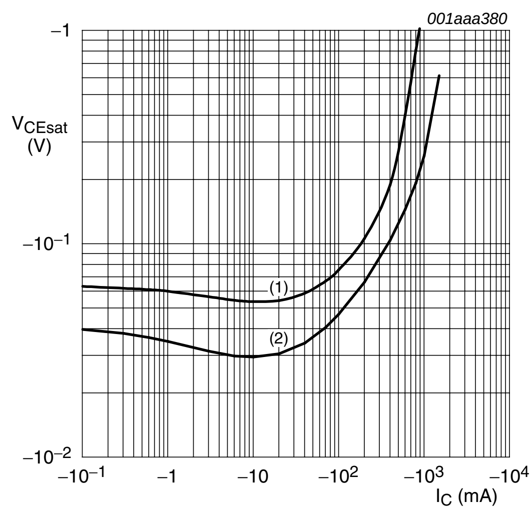
I_C/I_B = 10

(1) T_{amb} = 100 °C

(2) T_{amb} = 25 °C

(3) T_{amb} = −55 °C

Fig 5. Collector-emitter saturation voltage as a function of collector current; typical values

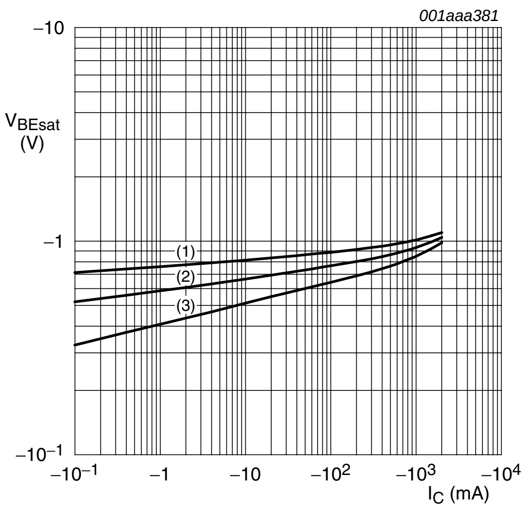


T_{amb} = 25 °C

(1) I_C/I_B = 50

(2) I_C/I_B = 20

Fig 6. Collector-emitter saturation voltage as a function of collector current; typical values



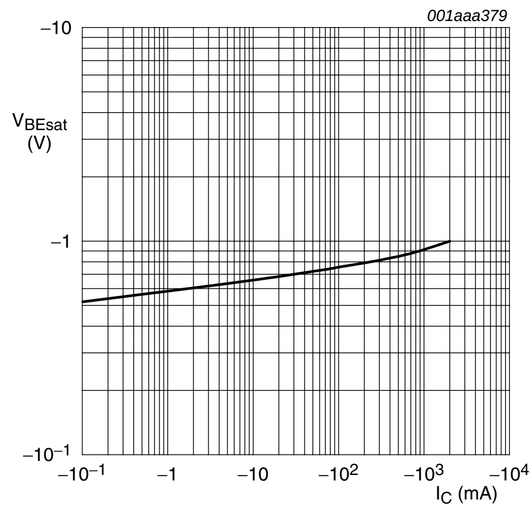
$I_C/I_B = 10$

(1) $T_{amb} = -55$ °C

(2) $T_{amb} = 25$ °C

(3) $T_{amb} = 100$ °C

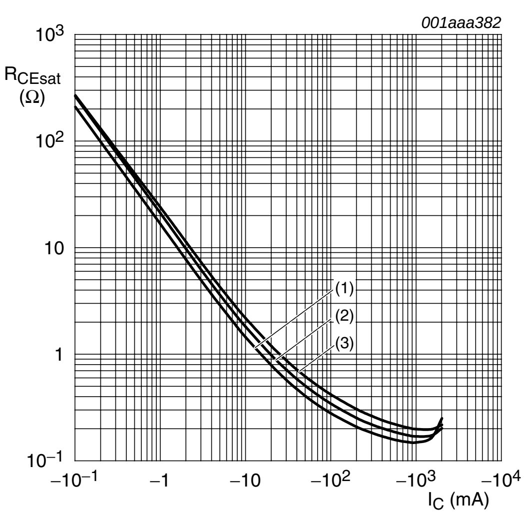
Fig 7. Base-emitter saturation voltage as a function of collector current; typical values



$I_C/I_B = 20$

$T_{amb} = 25$ °C

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values



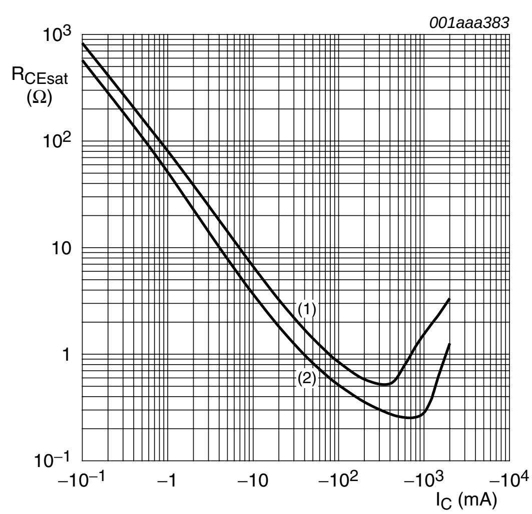
$I_C/I_B = 10$

(1) $T_{amb} = -55$ °C

(2) $T_{amb} = 25$ °C

(3) $T_{amb} = 100$ °C

Fig 9. Equivalent on-resistance as a function of collector current; typical values



$T_{amb} = 25$ °C

(1) $I_C/I_B = 50$

(2) $I_C/I_B = 20$

Fig 10. Equivalent on-resistance as a function of collector current; typical values

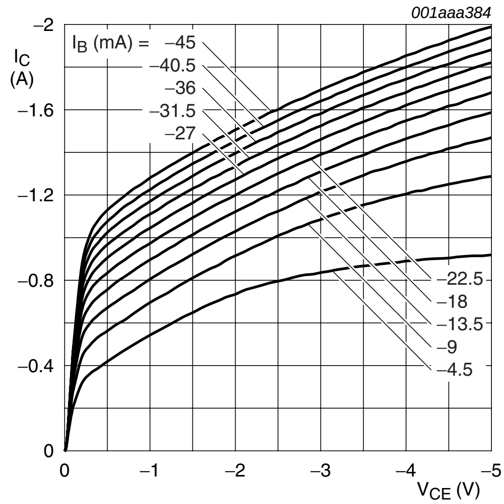
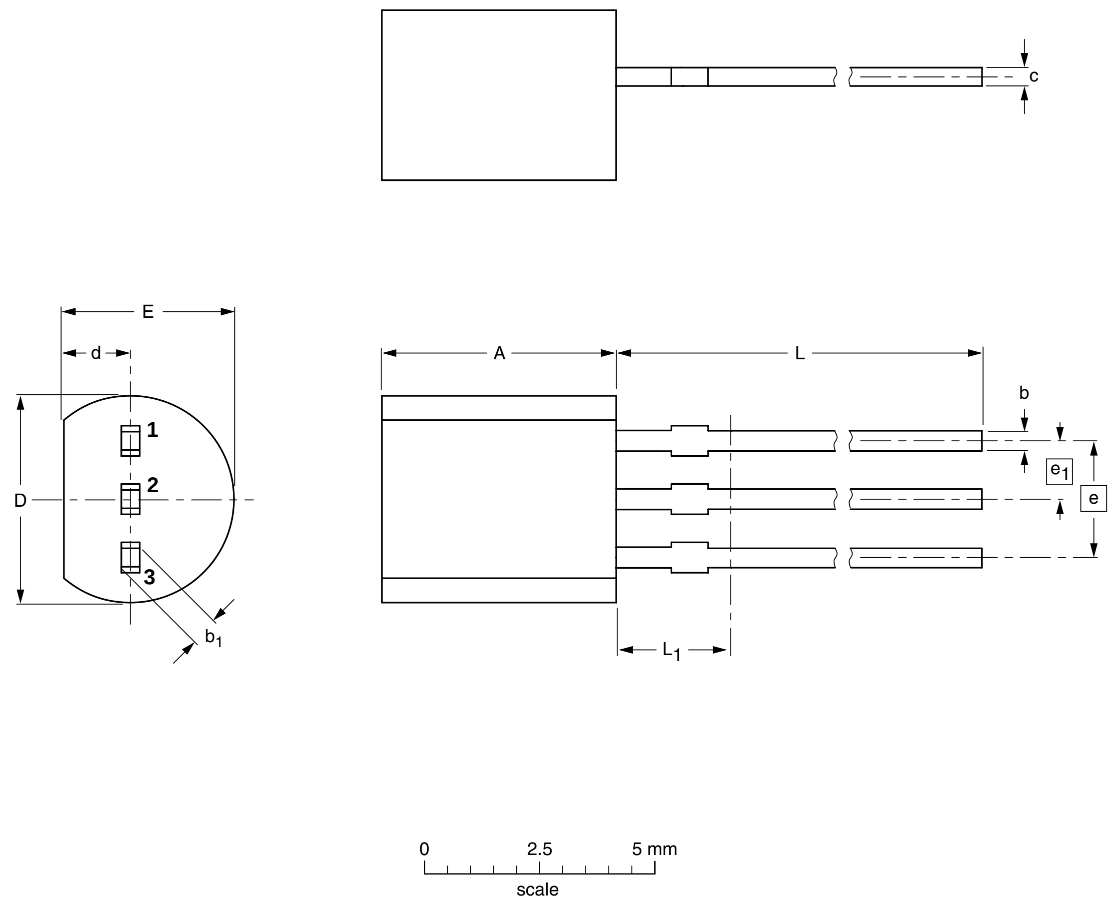


Fig 11. Collector current as a function of collector-emitter voltage; typical values

8. Package outline

Plastic single-ended leaded (through hole) package; 3 leads **SOT54**



DIMENSIONS (mm are the original dimensions)

UNIT	A	b	b_1	c	D	d	E	e	e_1	L	L_1(1) max.
mm	5.2 5.0	0.48 0.40	0.66 0.55	0.45 0.38	4.8 4.4	1.7 1.4	4.2 3.6	2.54	1.27	14.5 12.7	2.5

Note

1. Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT54		TO-92	SC-43A			~~04-06-28~~ 04-11-16

Fig 12. Package outline

9. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS9110S_3	20091121	Product data sheet	-	PBSS9110S_2
Modifications:	• This data sheet was changed to reflect the new company name NXP Semiconductors, including new legal definitions and disclaimers. No changes were made to the technical content. • Figure 9 “Equivalent on-resistance as a function of collector current; typical values”: updated • Figure 10 “Equivalent on-resistance as a function of collector current; typical values”: updated • Figure 11 “Collector current as a function of collector-emitter voltage; typical values”: updated • Figure 12 “Package outline”: updated			
PBSS9110S_2	20040816	Product data sheet	-	PBSS9110AS_1
PBSS9110AS_1	20040610	Product data sheet	-	-

10. Legal information

10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term ‘short data sheet’ is explained in section “Definitions”.

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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12. Contents

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